

Search Notes

Application/Control No.

10/646,918

Examiner

Huy D. Nguyen

Applicant(s)/Patent under
Reexamination

KIM, YOUNG-SE

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	566	8/4/2005	HN
	90.3		
	575.1		
	550.1		
	575.4		
	575.8		
348	207.1		
Updated	search	1/13/2006	HN
Updated	search	11/14/2006	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East; Text search (USPAT; US-PGPUB; EPO; JPO; DERWENT). See Search History Printout (Power outage on 8/3)	8/4/2005	HN
East; Text search (USPAT; US-PGPUB; EPO; JPO; DERWENT). See Search History Printout.	1/13/2006	HN
East; Text search (USPAT; US-PGPUB; EPO; JPO; DERWENT). See Search History Printout.	11/14/2006	HN